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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hideaki Kuwabara et al. Art Unit : 2815
Serial No. : 10/735,767 Examiner : George Eckert II
Filed : December 16, 2003 Confirmation No.: 4086
Title : SEMICONDUCTOR DEVICE AND METHOD FOR MANUFACTURING THE SAME

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), the listed U.S. patents are not enclosed and can be provided upon request.

This statement is being filed before the receipt of a first Office Action on the merits.
Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,


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Date: August 22, 2005

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AUG 22 2005Sheet 1 of 1

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 12732-189001	Application No. 10/735,767
Information Disclosure Statement by Applicant (Use several sheets if necessary)				Applicant Hideaki Kuwabara et al.	
(37 CFR §1.98(b))				Filing Date December 16, 2003	Group Art Unit 2815

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,861,666	01/19/1999	Bellaar			08/29/1996
	AB	6,312,304 B1	11/06/2001	Duthaler et al.			12/14/1999
	AC	6,441,474, B2	08/27/2002	Naitoh et al.			04/02/2001
	AD	6,883,934 B2	04/26/2005	Kawakami et al.			07/12/2001
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	